
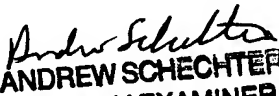
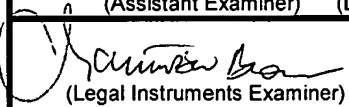


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/820,495	LEE ET AL.	
	Examiner	Art Unit	
	Wen-Ying P. Chen	2871	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
349		58			349	61			
INTERNATIONAL CLASSIFICATION					362	632	633		
G	0	2	F	1/1335					
G	0	2	F	1/133					
F	2	1	V	7/04					
				/					
				/					
W. Patty Chen Jan. 9, 2006 (Assistant Examiner) (Date)					 ANDREW SCHECHTER PRIMARY EXAMINER 1/23/06 (Date)			Total Claims Allowed: 18	
 (Legal Instruments Examiner) (Date)								O.G. Print Claim(s) 1	O.G. Print Fig. 2

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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